

AN1741 (AN6570), AN1741S (AN6570S), AN6573

Single Operational Amplifiers

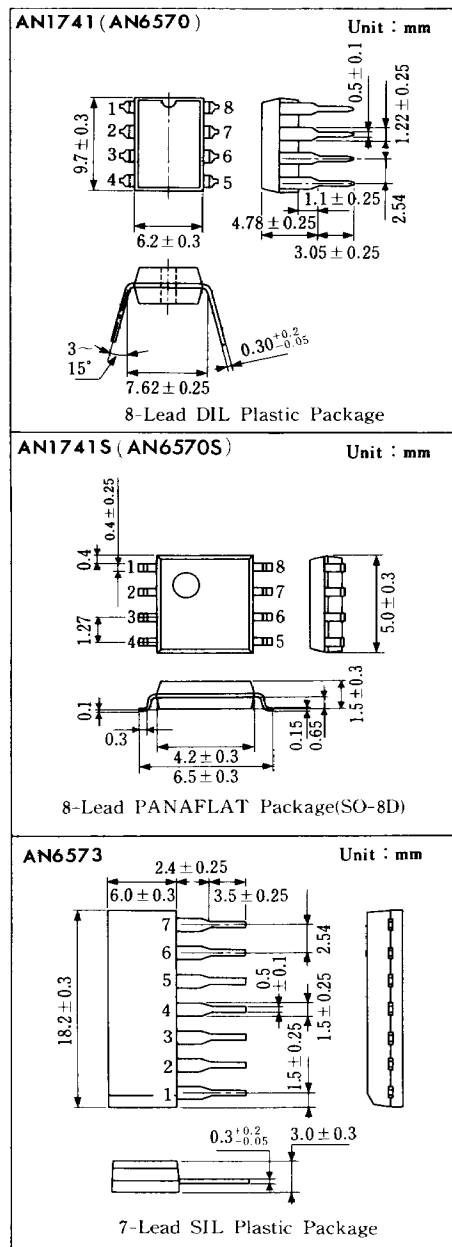
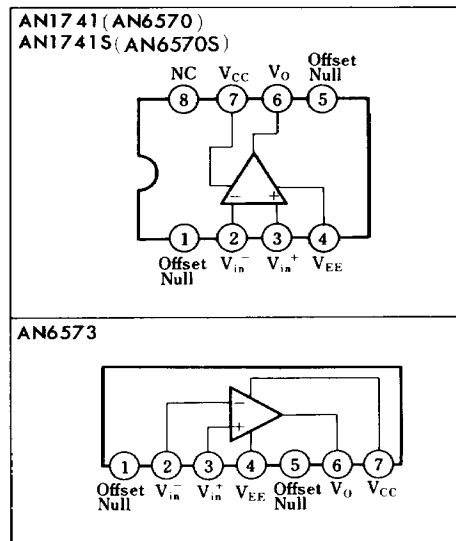
■ Outline

The AN1741 (AN6570), the AN1741S (AN6570S), and the AN6573 are single type operational amplifier with a phase compensation circuit built-in and also an output short-circuit protection circuit built-in, so that they are highly stable and can be used widely in various electronic circuits.

■ Features

- Phase compensation circuit
- High common mode input range, no latch-up
- Short circuit protection
- Low input offset voltage : $V_{I(offset)} = 0.5 \text{ mV typ.}$
- Low input offset current : $I_{IO} = 10 \text{ nA typ.}$
- Offset nulling circuit

■ Block Diagrams



■ Pin

<AN1741 (AN6570), AN1741S (AN6570S)>

Pin No.	Pin Name
1	Offset Null
2	Invert Input
3	Non Invert Input
4	V_{EE}
5	Offset Null
6	Output
7	V_{CC}
8	NC

<AN6573>

Pin No.	Pin Name
1	Offset Null
2	Invert Input
3	Non Invert Input
4	V_{EE}
5	Offset Null
6	Output
7	V_{CC}

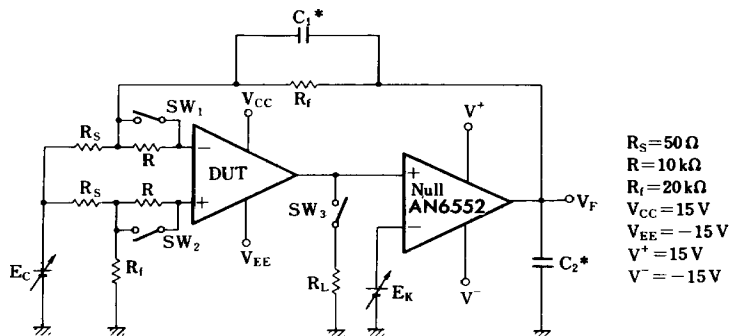
■ Absolute Maximum Ratings ($T_a = 25^\circ\text{C}$)

Item		Symbol	Rating	Unit
Voltage	Supply Voltage	V_{CC}	± 18	V
	Differential Input Voltage	V_{ID}	± 30	V
	Common-Mode Input Voltage	V_{ICM}	± 15	V
Power Dissipation	AN1741 (AN6570), AN6573	P_D	500	mW.
	AN1741S (AN6570S)		360	
Operating Ambient Temperature		T_{OPR}	$-20 \sim +75$	$^{\circ}\text{C}$
Storage Temperature	AN1741 (AN6570), AN6573	T_{STG}	$-55 \sim +150$	$^{\circ}\text{C}$
	AN1741S (AN6570S)		$-55 \sim +125$	

■ Electrical Characteristics ($V_{CC} = 15\text{V}$, $V_{EE} = -15\text{V}$, $T_a = 25^\circ\text{C}$)

Item	Symbol	Test Circuit	Condition	min.	typ.	max.	Unit
Input Offset Voltage	$V_{I(offset)}$	1	$R_s \leq 10\text{k}\Omega$		0.5	4	mV
Input Offset Current	I_{IO}	1			10	100	nA
Input Bias Current	I_{Bias}	1			50	250	nA
Voltage Gain	G_V	1	$R_L \geq 2\text{k}\Omega$, $V_o = \pm 10\text{V}$	86	106		dB
Maximum Output Voltage	$V_{O(max.)}$	2	$R_L \geq 10\text{k}\Omega$	± 12	± 14		V
		2	$R_L \geq 2\text{k}\Omega$	± 10	± 13		V
Common-Mode Input Voltage Width	V_{CM}	3		± 12	± 13		V
Common-Mode Rejection Ratio	CMR	1	$R_s \leq 10\text{k}\Omega$	70	90		dB
Supply Voltage Rejection Ratio	SVR	1	$R_s \leq 10\text{k}\Omega$		30	150	$\mu\text{V/V}$
Supply Current	I_{CC}	4	$R_L = \infty$			2.8	mA
Power Consumption	P_C	4	$R_L = \infty$			85	mW
Output Short-Circuit Current	$I_{O(short)}$	2			± 20		mA
Slew Rate	SR	5			0.7		V/ μs

Test Circuit 1 ($V_{I(\text{offset})}$, I_{IO} , I_{Bias} , G_V , CMR , SVR)

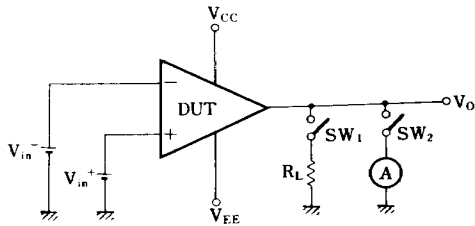


* C_1 and C_2 are capacitors for the prevention of oscillation.

Item	Measurement Conditions
Input Offset Voltage	V_{F1} is measured with the SW_1 , SW_2 and SW_3 set to OFF and $E_C = E_K = 0V$. Can be given by $V_{I(\text{offset})} = \frac{V_{F1}}{400} (V)$
Input Offset Current	V_{F2} is measured with the SW_1 and SW_2 set to ON, the SW_3 set to OFF and $E_C = E_K = 0V$. Can be given by $I_{IO} = \frac{ V_{F2} - V_{F1} }{4 \times 10^6} (A)$
Input Bias Current	V_{F3} is measured with the SW_3 set to OFF, $E_C = E_K = 0V$, the SW_1 set to ON and the SW_2 set to OFF. V_{F4} is measured with the SW_1 and SW_2 reversed. Can be given by $I_{Bias} = \frac{ V_{F3} - V_{F4} }{8 \times 10^6} (A)$
Voltage Gain	V_{F5} is measured with the SW_1 , SW_2 and SW_3 set to ON, $E_C = 0V$ and $E_K = 10V$. $V_{F'5}$ is measured with $E_K = -10V$. Can be given by $G_V = 20 \log \left(\frac{8000}{ V_{F5} - V_{F'5} } \right)$
Common-Mode Rejection Ratio	V_{F6} is measured with both the SW_1 and SW_2 set to ON, the SW_3 set to OFF, $E_K = 0V$ and $E_C = 5V$. $V_{F'6}$ is measured with $E_C = -5V$. Can be given by $CMR = 20 \log \left(\frac{4000}{ V_{F6} - V_{F'6} } \right)$
Supply Voltage Rejection Ratio I	V_{F7} is measured with both the SW_1 and SW_2 set to ON, the SW_3 set to OFF, $E_K = E_C = 0V$ and $V_{CC} = 10V$. Can be given by $SVR(+) = \frac{ V_{F7} - V_{F2} }{2 \times 10^3}$
Supply Voltage Rejection Ratio II	V_{F8} is measured with both the SW_1 and SW_2 set to ON, the SW_3 set to OFF, $E_K = E_C = 0V$ and $V_{EE} = -10V$. Can be given by $SVR(-) = \frac{ V_{F8} - V_{F2} }{2 \times 10^3}$

Note) When not specified in the above table, $V_{CC} = 15V$ and $V_{EE} = -15V$.

Test Circuit 2 ($V_{O(max.)}$, $I_{O(short)}$)



$$V_{CC} = 15V$$

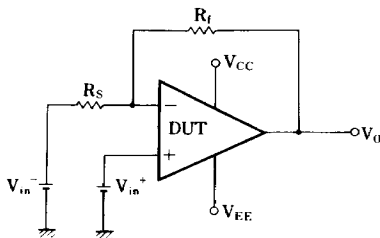
$$V_{EE} = -15V$$

$$R_L = 2k\Omega \text{ or } 10k\Omega$$

$$V_{O(max.)} : SW_1 : \text{ON}, SW_2 : \text{OFF}$$

$$I_{O(short)} : SW_1 : \text{OFF}, SW_2 : \text{ON}$$

Test Circuit 3 (V_{CM})



$$V_{CC} = 15V$$

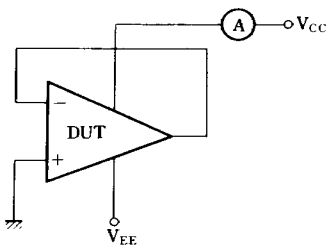
$$V_{EE} = -15V$$

$$R_S = 200\Omega$$

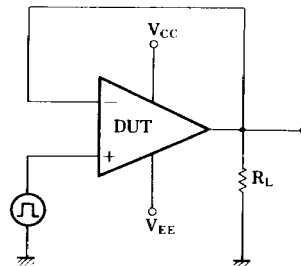
$$R_f = 2k\Omega$$

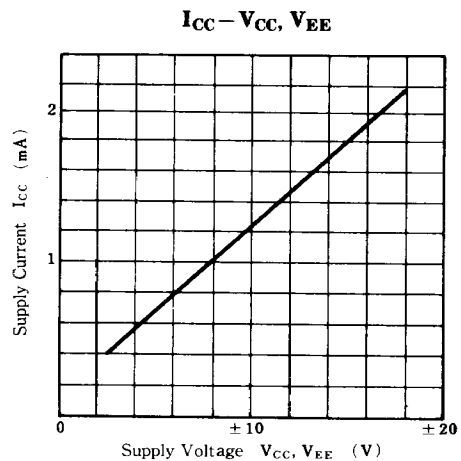
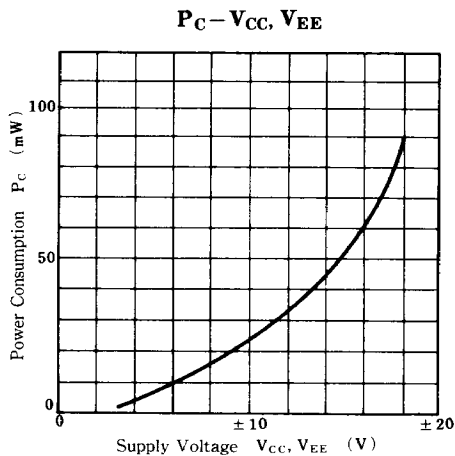
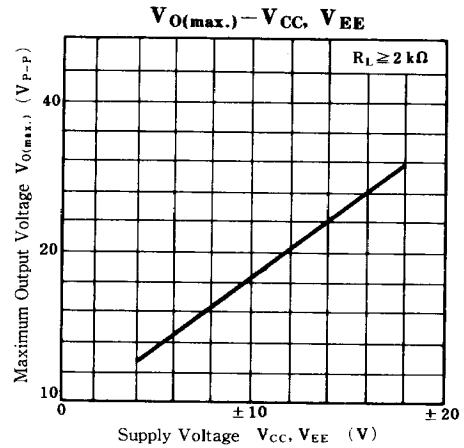
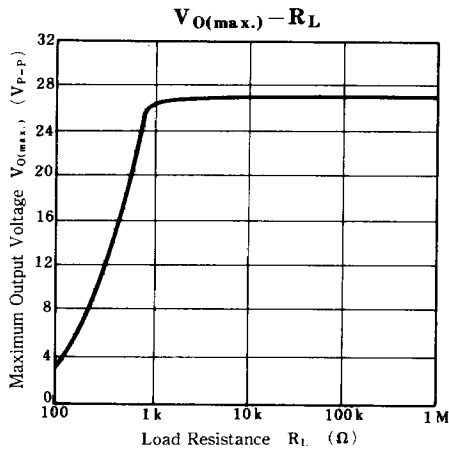
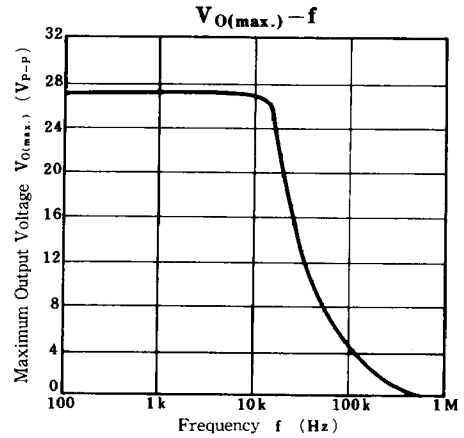
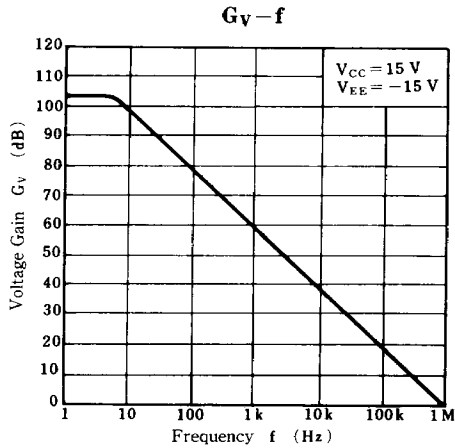
Note) Apply a voltage of $|V_{in+}| > 12V$ and check $V_O = V_{in+} + \frac{R_f}{R_S}(V_{in+} - V_{in-})$

Test Circuit 4 (I_{CC} , P_C)

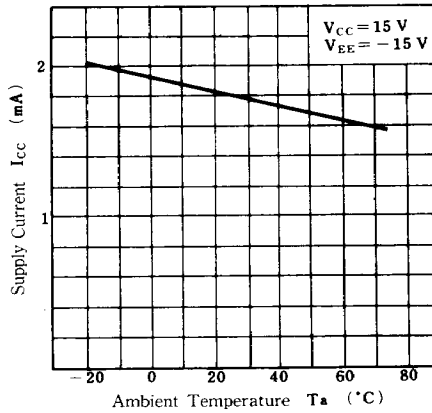


Test Circuit 5 (SR)

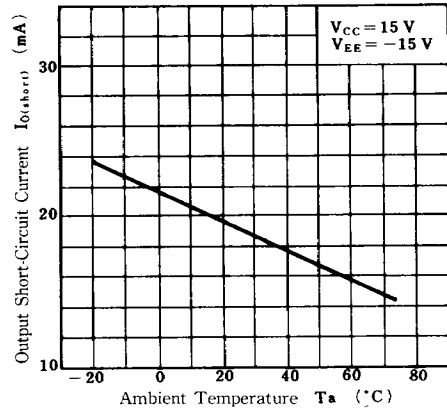




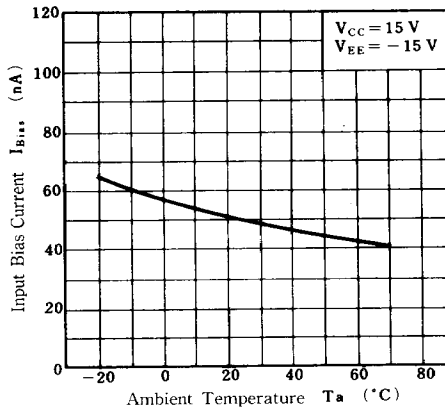
$I_{CC} - T_a$



$I_{O(short)} - T_a$



$I_{Bias} - T_a$



■ Application Circuit

Differential Amplifier

